Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/889,321	TAKAHAMA, YOUSUKE	
Examiner	Art Unit	
Anne Marie S. Wehbe	1633	

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SEARCHED						
Class	Subclass	Date	Examiner			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEAR (INCLUDING SI	CH NOTE)
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search updated		1/17/2007	AW
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